Universal Analog Measurement Module



1, 4, or 8 universal analog input channels

Voltage, current, resistance, Pt100, Pt1000, thermocouples, bridges



e.bloxx A1 Technical Data

Analog Input

Accuracy 0.01 % typical

0.02 % in controlled environment¹

0.05 % in industrial area2

Repeatability 0.003 % typical (within 24 h)

Measurement	Range	Accuracy	Resolution
Voltage	±10 V	±2 mV	40 μV
	±1 V	±0.2 mV	4 μV
	±100 mV	±20 μV	0.4 μV
	±10 mV	±10 μV	0.04 μV
Current	4-20 mA	±4 μA	80 nA
(internal shunt 100 Ω)	±20 mA	±4 μA	80 nA
Resistance	$4 \text{ k}\Omega$	±1 Ω	0.05Ω
(2, 3 and 4 wire)	$2 \mathrm{k}\Omega$	$\pm 0.6 \Omega$	0.03Ω
Bridge	±1000 mV/V	±1 mV/V	50 μV/V
(Supply 5 VDC/120 Ω)	±200 mV/V	±200 μV/V	10 μV/V
	±20 mV/V	±20 μV/V	1 μV/V
	±8 mV/V	±8 μV/V	$0.4 \mu V/V$
	±2 mV/V	±2 μV/V	$0.1 \mu V/V$
RTD (2, 3 and 4 wire)			
Pt100 (-200 to +850 °C)		±0.5 °C	0.1 °C
Pt100 (-200 to +250 °C)		±0.2 °C	0.01 °C
Pt1000 (-200 to +850 °C)		±1 °C	0.1 °C
Pt1000 (-200 to +140 °C)		±0.3 °C	0.01 °C
Thermocouples			

better than ±5 °C Type B: Type E, J, K, L, T, U better than ±1 °C Type N better than ±2 °C Type R, S better than ±3 °C

Input resistance $> 10 \ \mathrm{M}\Omega$ Common mode voltage 500 V permanent Linearity deviation 0.01 % of the final value Signal to noise ratio voltage measurement

1 kHz 90 dB 1 Hz 120 dB

Temperature influence

on zero $1\mu V / 10 K$ on sensitivity $0.02~\%\,/\,10~K$

Long-time drift 1 μV / 24 h; 0.1 μA / 24 h

Analog/Digital Conversion

Resolution

1000 samples/sec for voltage, current Sample rate

potentiometer, bridge

10 samples/sec for resistance, RTD



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